

Isolated Sigma-Delta Modulator

FEATURES

- ▶ 10 MHz clock rate
- Second-order modulator
- ▶ 16 bits no missing codes
- ▶ ±2 LSB INL typical at 16 bits
- ▶ 3.5 µV/°C maximum offset drift
- On-board digital isolator
- On-board reference
- ▶ Low power operation: 18 mA maximum at 5.25 V
- ▶ -40°C to +105°C operating range
- ▶ 16-lead SOIC package
- Safety and regulatory approvals
 - ▶ UL 1577
 - ▶ V_{ISO} = 5000 V rms for 1 minute
 - ▶ IEC / CSA 62368-1
 - ▶ IEC / CSA 61010-1
 - ▶ DIN EN IEC 60747-17 (VDE 0884-17)
 - ► V_{IORM} = 645 V peak

APPLICATIONS

- AC motor controls
- ▶ Data acquisition systems
- ▶ A/D + opto-isolator replacements

GENERAL DESCRIPTION

The AD7400 is a second-order, sigma-delta $(\Sigma\text{-}\Delta)$ modulator that converts an analog input signal to a high speed, 1-bit data stream with on-chip digital isolation based on Analog Devices, Inc. <code>iCoupler®</code> technology. The AD7400 operates from a 5 V power supply and accepts a differential input signal of ±200 mV (±320 mV full scale). The analog input is continuously sampled by the analog modulator, eliminating the need for external sample-and-hold circuitry. The input information is contained in the output stream as a density of ones with a data rate of 10 MHz. The original information can be reconstructed with an appropriate digital filter. The serial I/O can use a 5 V or a 3 V supply ($V_{\rm DD2}$).

The serial interface is digitally isolated. High speed CMOS, combined with monolithic air core transformer technology, means the on-chip isolation provides outstanding performance characteristics superior to alternatives such as optocoupler devices. The part contains an on-chip reference. The AD7400 is offered in a 16-lead SOIC and has an operating temperature range of −40°C to +105°C.

An external clock version, AD7401, is also available.

FUNCTIONAL BLOCK DIAGRAM

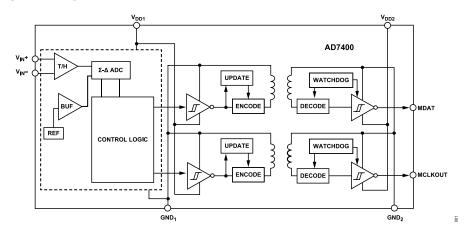


Figure 1.

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¹ Protected by U.S. Patents 5,952,849; 6,873,065; and 7,075,329.

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REVISION HISTORY		
9/2024—Rev. H to Rev. I		
Changed Master to Main (Throughout)		1
Changes to Features Section		1
Changes to Table 3		4
Changes to Regulatory Information Section and Table	4	5
Changed DIN V VDE V 0884-10 (VDE V 0884-10) Ins 60747-17 (VDE 0884-17) Insulation Characteristics S		5
Changes to Table 5 and Figure 4 Caption		
Deleted Table 7; Renumbered Sequentially		
Deleted Insulation Lifetime Section and Figure 29 to F	igure 51, Renumbered Sequentially	10

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SPECIFICATIONS

 V_{DD1} = 4.5 V to 5.25 V, V_{DD2} = 3 V to 5.5 V, V_{IN} + = -200 mV to +200 mV, and V_{IN} - = 0 V (single-ended); T_A = T_{MIN} to T_{MAX} , f_{MCLK} = 10 MHz, tested with Sinc³ filter, 256 decimation rate, as defined by Verilog code, unless otherwise noted. Temperature range is -40°C to +85°C.

Table 1.

	Y Version ^{1, 2}			_	
Parameter	Min Typ Max		Unit	Test Conditions/Comments	
STATIC PERFORMANCE					
Resolution	16			Bits	Filter output truncated to 16 bits
Integral Nonlinearity ³			±15	LSB	-40°C to +85°C; ±2 LSB typical
			±25	LSB	>85°C to 105°C
Differential Nonlinearity ³			±0.9	LSB	Guaranteed no missing codes to 16 bits
Offset Error ³			±0.5	mV	
		±50		μV	T _A = 25°C
Offset Drift vs. Temperature			3.5	μV/°C	-40°C to +105°C
		1		μV/°C	
Offset Drift vs. V _{DD1}		120		μV/V	
Gain Error ³			±1	mV	
Gain Error Drift vs. Temperature		23		μV/°C	-40°C to +105°C
Gain Error Drift vs. V _{DD1}		110		μV/V	
ANALOG INPUT					
Input Voltage Range	±200		±200	mV	For specified performance; full range ±320 mV
Dynamic Input Current			±8	μA	V _{IN} + = 400 mV, V _{IN} - = 0 V
		±0.5		μA	$V_{IN} + = V_{IN} - = 0 V$
Input Capacitance		10		pF	
DYNAMIC SPECIFICATIONS					V _{IN} + = 35 Hz, 400 mV p-p sine
Signal-to-(Noise + Distortion) Ratio (SINAD) ³	70			dB	-40°C to +85°C
	65			dB	>85°C to 105°C
		79		dB	
Signal-to-Noise Ratio (SNR)	71			dB	-40°C to +105°C
Total Harmonic Distortion (THD) ³		-88		dB	
Peak Harmonic or Spurious Noise (SFDR) ³		-88		dB	
Effective Number of Bits (ENOB) ³	11.5			Bits	
Isolation Transient Immunity ³	25			kV/µs	
		30		kV/µs	
LOGIC OUTPUTS					
Output High Voltage, V _{OH}	V _{DD2} - 0.1			V	Ι _Ο = -200 μΑ
Output Low Voltage, V _{OL}			0.4	V	I _O = +200 μA
POWER REQUIREMENTS					
V_{DD1}	4.5		5.25	V	
V_{DD2}	3		5.5	V	
l _{DD1} ⁴			13	mA	V _{DD1} = 5.25 V
I _{DD2} ⁵			6	mA	V _{DD2} = 5.5 V
			4	mA	V _{DD2} = 3.3 V

¹ Temperature range is −40°C to +85°C.

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² All voltages are relative to their respective ground.

³ See the Terminology section.

⁴ See Figure 14.

⁵ See Figure 15.

SPECIFICATIONS

TIMING SPECIFICATIONS

 V_{DD1} = 4.5 V to 5.25 V, V_{DD2} = 3 V to 5.5 V, T_A = T_{MAX} to T_{MIN} , unless otherwise noted. Sample tested during initial release to ensure compliance.

Table 2.

Parameter	Limit at T _{MIN} , T _{MAX}	Unit	Description
f _{MCLKOUT} 1	10	MHz typ	Main clock output frequency
	9/11	MHz min/MHz max	Main clock output frequency
t ₁ ²	40	ns max	Data access time after MCLK rising edge
t2 ²	10	ns min	Data hold time after MCLK rising edge
t_3	0.4 × t _{MCLKOUT}	ns min	Main clock low time
t ₄	0.4 × t _{MCLKOUT}	ns min	Main clock high time

¹ Mark space ratio for clock output is 40/60 to 60/40.

 $^{^{2}}$ Measured with the load circuit of Figure 2 and defined as the time required for the output to cross 0.8 V or 2.0 V.

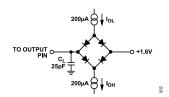


Figure 2. Load Circuit for Digital Output Timing Specifications

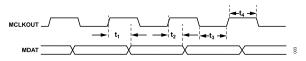


Figure 3. Data Timing

INSULATION AND SAFETY-RELATED SPECIFICATIONS

Table 3.

Parameter	Symbol	Value	Unit	Conditions
Rated Dielectric Insulation Voltage	V _{ISO}	5000	V rms	1-minute duration
Minimum External Air Gap (Clearance)	L(I01)	7.8 ^{1, 2}	mm	Measured from input terminals to output terminals, shortest distance through air
Minimum External Tracking (Creepage)	L(I02)	7.8	mm	Measured from input terminals to output terminals, shortest distance path along body
Minimum Internal Gap (Internal Clearance)		18	μm	Insulation distance through insulation
Tracking Resistance (Comparative Tracking Index)	CTI	>400	V	DIN IEC 112/VDE 0303 Part 1
Material Group		II		Material group per IEC 60664-1

¹ In accordance with IEC 62368-1 guidelines for the measurement of creepage and clearance distances for a pollution degree of 2 and altitudes ≤2000 m.

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Consideration must be given to pad layout to ensure the minimum required distance for clearance is maintained.

SPECIFICATIONS

REGULATORY INFORMATION

The AD7400 certification approvals are listed in Table 4.

Table 4. Regulatory Information

Regulatory Agency	Standard Certification/Approval	File
UL	1577	File E214100
	Single protection, 5000 V rms isolation voltage ¹	
CSA	IEC / CSA 62368-1	File No. 205078
	Basic insulation, 780 V rms	
	Reinforced insulation, 390 V rms	
	IEC / CSA 61010-1	
	Basic Insulation, 600 V rms	
	Overvoltage category III	
	Reinforced insulation, 300 V rms	
Not CQC Certified		
VDE	DIN EN IEC 60747-17 (VDE 0884-17)	Certificate No. 40011599
	Reinforced insulation, 645 V peak ²	

¹ In accordance with UL 1577, each AD7400 is proof tested by applying an insulation test voltage ≥ 6000 V rms for 1 second (current leakage detection limit = 15 μA).

DIN EN IEC 60747-17 (VDE 0884-17) INSULATION CHARACTERISTICS

This isolator is suitable for reinforced electrical isolation only within the safety limit data. Maintenance of the safety data is ensured by means of protective circuits.

Table 5.

Description	Symbol	Characteristic	Unit
OVERVOLTAGE CATEGORY PER IEC 60664-1			
For Rated Mains Voltage ≤ 300 V rms		I–IV	
For Rated Mains Voltage ≤ 450 V rms		I–II	
For Rated Mains Voltage ≤ 600 V rms		I–II	
CLIMATIC CLASSIFICATION		40/105/21	
POLLUTION DEGREE (DIN VDE 0110, Table 1)		2	
MAXIMUM REPETITIVE ISOLATION VOLTAGE	V _{IORM}	645	V peak
MAXIMUM WORKING INSULATION VOLTAGE	V _{IOWM}	456	V rms
INPUT-TO-OUTPUT TEST VOLTAGE, METHOD B1			
V _{IORM} × 1.875 = V _{PR} , 100% Production Test, t _m = 1 sec, Partial Discharge < 5 pC	V _{PR}	1209	V peak
INPUT-TO-OUTPUT TEST VOLTAGE, METHOD A	V _{PR}		
After Environmental Test Subgroup 1		1032	V peak
V _{IORM} × 1.6 = V _{PR} , t _m = 60 sec, Partial Discharge < 5 pC			
After Input and/or Safety Test Subgroup 2/3		774	V peak
$V_{IORM} \times 1.2 = V_{PR}$, $t_m = 60$ sec, Partial Discharge < 5 pC			
MAXIMUM TRANSIENT ISOLATION VOLTAGE (TRANSIENT OVERVOLTAGE, t _{TR} = 10 sec)	V _{TR}	6000	V peak
MAXIMUM IMPULSE VOLTAGE	V _{IMP}	6000	V peak
Tested in Air, 1.2 µs/50 µs Waveform per IEC 61000-4-5			
MAXIMUM SURGE ISOLATION VOLTAGE	V _{IOSM}	N/A	V peak
Tested in Oil, 1.2 μs/50 μs Waveform per IEC 61000-4-5, V _{TEST} = V _{IOSM} × 1.3 OR ≥ 10 kV			
SAFETY-LIMITING VALUES (MAXIMUM VALUE ALLOWED IN THE EVENT OF A FAILURE, ALSO SEE Figure 4)			

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In accordance with DIN EN IEC 60747-17 (VDE 0884-17), each AD7400 is proof tested by applying an insulation test voltage ≥ 1671 V peak for 1 second (partial discharge detection limit = 5 pC).

SPECIFICATIONS

Table 5. (Continued)

Description	Symbol	Characteristic	Unit
Case Temperature	T _S	150	°C
Side 1 Current	I _{S1}	265	mA
Side 2 Current	I _{S2}	335	mA
INSULATION RESISTANCE AT T _S , V _{IO} = 500 V	R _S	>109	Ω

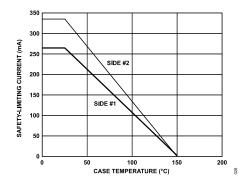


Figure 4. Thermal Derating Curve, Dependence of Safety-Limiting Values with Case Temperature per DIN EN IEC 60747-17 (VDE 0884-17)

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ABSOLUTE MAXIMUM RATINGS

 T_A = 25°C, unless otherwise noted. All voltages are relative to their respective ground.

Table 6.

Parameter	Rating	
V _{DD1} to GND ₁	-0.3 V to +6.5 V	
V _{DD2} to GND ₂	-0.3 V to +6.5 V	
Analog Input Voltage to GND ₁	-0.3 V to V _{DD1} + 0.3 V	
Output Voltage to GND ₂	-0.3 V to V _{DD2} + 0.3 V	
Input Current to Any Pin Except Supplies ¹	±10 mA	
Operating Temperature Range	-40°C to +105°C	
Storage Temperature Range	-65°C to +150°C	
Junction Temperature	150°C	
SOIC Package		
θ_{JA} Thermal Impedance	89.2°C/W	
θ_{JC} Thermal Impedance	55.6°C/W	
Resistance (Input-to-Output), R _{I-O}	10 ¹² Ω	
Capacitance (Input-to-Output), C _{I-O} ²	1.7 pF typ	
Pb-Free Temperature, Soldering		
Reflow	260 (+0)°C	
ESD	1.5 kV	

¹ Transient currents of up to 100 mA do not cause SCR to latch-up.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

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² f = 1 MHz.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

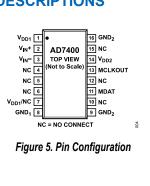


Figure 5. Pin Configuration

Table 7. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	V _{DD1}	Supply Voltage. 4.5 V to 5.25 V. This is the supply voltage for the isolated side of the AD7400 and is relative to GND ₁ .
2	V _{IN} +	Positive Analog Input. Specified range of ±200 mV.
3	V _{IN} -	Negative Analog Input. Normally connected to GND ₁ .
4 to 6, 10, 12, 15	NC	No Connect.
7	V _{DD1} /NC	Supply Voltage. 4.5 V to 5.25 V. This is the supply voltage for the isolated side of the AD7400 and is relative to GND ₁ .
		No Connect (NC). If desired, Pin 7 may be allowed to float. It should not be tied to ground. The AD7400 will operate normally provided that the supply voltage is applied to Pin 1.
8	GND ₁	Ground 1. This is the ground reference point for all circuitry on the isolated side.
9, 16	GND ₂	Ground 2. This is the ground reference point for all circuitry on the nonisolated side.
11	MDAT	Serial Data Output. The single bit modulator output is supplied to this pin as a serial data stream. The bits are clocked out on the rising edge of the MCLKOUT output and valid on the following MCLKOUT rising edge.
13	MCLKOUT	Main Clock Logic Output. 10 MHz typical. The bit stream from the modulator is valid on the rising edge of MCLKOUT.
14	V_{DD2}	Supply Voltage. 3 V to 5.5 V. This is the supply voltage for the nonisolated side and is relative to GND ₂ .

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TYPICAL PERFORMANCE CHARACTERISTICS

T_A = 25°C, using a 20 kHz brick wall filter, unless otherwise noted.

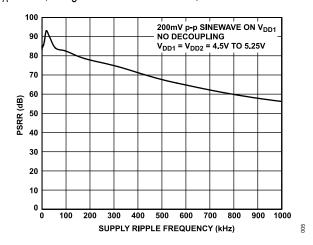


Figure 6. PSRR vs. Supply Ripple Frequency Without Supply Decoupling (1 MHz Filter Used)

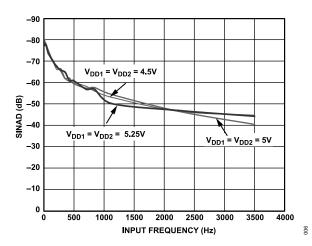


Figure 7. SINAD vs. Analog Input Frequency for Various Supply Voltages

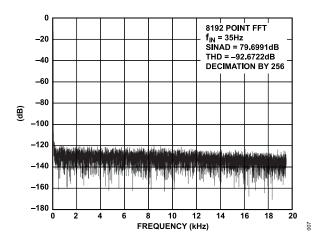


Figure 8. Typical FFT, ±200 mV Range (Using Sinc³ Filter, 256 Decimation Rate)

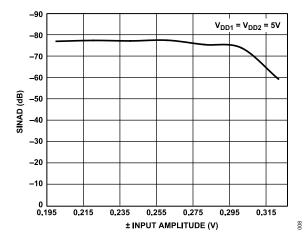


Figure 9. SINAD vs. V_{IN}

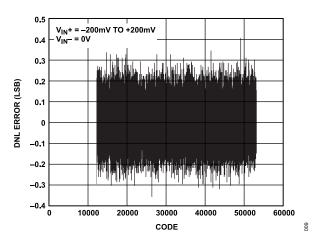


Figure 10. Typical DNL, ±200 mV Range (Using Sinc³ Filter, 256 Decimation Rate)

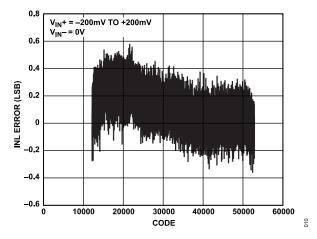


Figure 11. Typical INL, ±200 mV Range (Using Sinc³ Filter, 256 Decimation Rate)

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TYPICAL PERFORMANCE CHARACTERISTICS

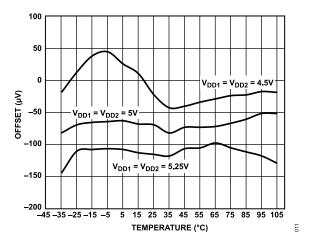


Figure 12. Offset Drift vs. Temperature for Various Supply Voltages

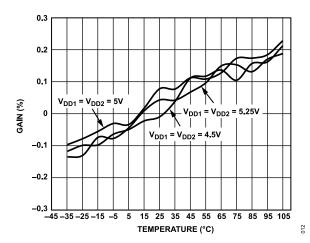


Figure 13. Gain Error Drift vs. Temperature for Various Supply Voltages

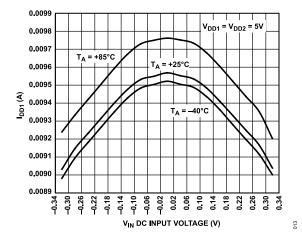


Figure 14. I_{DD1} vs. V_{IN} at Various Temperatures

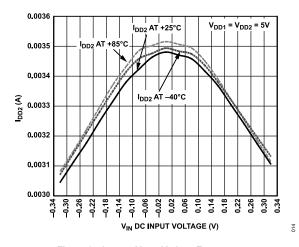


Figure 15. I_{DD2} vs. V_{IN} at Various Temperatures

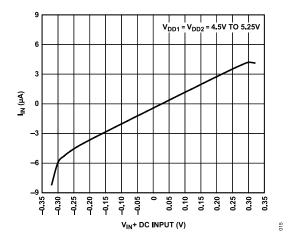


Figure 16. I_{IN} vs. V_{IN}+ DC Input

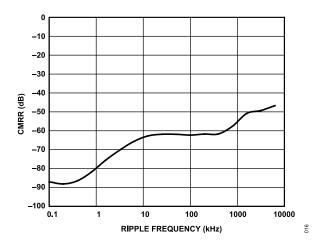


Figure 17. CMRR vs. Common-Mode Ripple Frequency

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TYPICAL PERFORMANCE CHARACTERISTICS

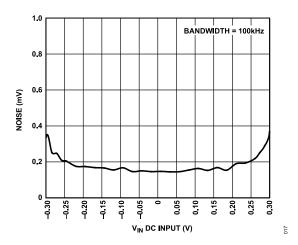


Figure 18. RMS Noise Voltage vs. V_{IN} DC Input

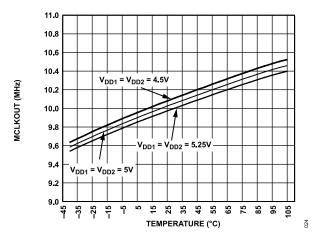


Figure 19. MCLKOUT vs. Temperature for Various Supplies

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TERMINOLOGY

Differential Nonlinearity

Differential nonlinearity is the difference between the measured and the ideal 1 LSB change between any two adjacent codes in the ADC.

Integral Nonlinearity

Integral nonlinearity is the maximum deviation from a straight line passing through the endpoints of the ADC transfer function. The endpoints of the transfer function are specified negative full scale, -200~mV (V $_\text{IN}+-V_\text{IN}-$), Code 12,288 for the 16-bit level, and specified positive full scale, +200~mV (V $_\text{IN}+-V_\text{IN}-$), Code 53,248 for the 16-bit level.

Offset Error

Offset error is the deviation of the midscale code (Code 32,768 for the 16-bit level) from the ideal V_{IN} + – V_{IN} – (that is, 0 V).

Gain Error

Gain error includes both positive full-scale gain error and negative full-scale gain error. Positive full-scale gain error is the deviation of the specified positive full-scale code (53,248 for the 16-bit level) from the ideal V_{IN} + – V_{IN} – (+200 mV) after the offset error is adjusted out. Negative full-scale gain error is the deviation of the specified negative full-scale code (12,288 for the 16-bit level) from the ideal V_{IN} + – V_{IN} – (–200 mV) after the offset error is adjusted out. Gain error includes reference error.

Signal-to-(Noise + Distortion) Ratio (SINAD)

This ratio is the measured ratio of signal-to-(noise + distortion) at the output of the ADC. The signal is the rms amplitude of the fundamental. Noise is the sum of all nonfundamental signals up to half the sampling frequency ($f_{\rm S}/2$), excluding dc. The ratio is dependent on the number of quantization levels in the digitization process; the more levels, the smaller the quantization noise. The theoretical signal-to-(noise + distortion) ratio for an ideal N-bit converter with a sine wave input is given by

Signal-to-(Noise + Distortion) =
$$(6.02N + 1.76) dB$$
 (1)

Therefore, for a 12-bit converter, this is 74 dB.

Effective Number of Bits (ENOB)

The ENOB is defined by

$$ENOB = (SINAD - 1.76)/6.02$$
 (2)

Total Harmonic Distortion (THD)

THD is the ratio of the rms sum of harmonics to the fundamental. For the AD7400, it is defined as

$$THD\left(dB\right) = 20\log\frac{\sqrt{{v_2}^2 + {v_3}^2 + {v_4}^2 + {v_5}^2 + {v_6}^2}}{v_1}$$
(3)

where:

 V_1 is the rms amplitude of the fundamental.

 V_2 , V_3 , V_4 , V_5 , and V_6 are the rms amplitudes of the second through the sixth harmonics.

Peak Harmonic or Spurious Noise

Peak harmonic or spurious noise is defined as the ratio of the rms value of the next largest component in the ADC output spectrum (up to $f_{\rm S}/2$, excluding dc) to the rms value of the fundamental. Normally, the value of this specification is determined by the largest harmonic in the spectrum, but for ADCs where the harmonics are buried in the noise floor, it is a noise peak.

Common-Mode Rejection Ratio (CMRR)

CMRR is defined as the ratio of the power in the ADC output at ± 200 mV frequency, f, to the power of a 200 mV p-p sine wave applied to the common-mode voltage of V_{IN} + and V_{IN} - of frequency f_{S} , expressed as

$$CMRR (dB) = 10log(Pf/Pf_S)$$
(4)

where:

Pf is the power at frequency f in the ADC output. Pf_S is the power at frequency f_S in the ADC output.

Power Supply Rejection Ratio (PSRR)

Variations in power supply affect the full-scale transition but not converter linearity. PSRR is the maximum change in the specified full-scale (±200 mV) transition point due to a change in power supply voltage from the nominal value (see Figure 6).

Isolation Transient Immunity

The isolation transient immunity specifies the rate of rise/fall of a transient pulse applied across the isolation boundary beyond which clock or data is corrupted. (It was tested using a transient pulse frequency of 100 kHz.)

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THEORY OF OPERATION

CIRCUIT INFORMATION

The AD7400 isolated Σ - Δ modulator converts an analog input signal into a high speed (10 MHz typical), single-bit data stream; the time average of the modulator's single-bit data is directly proportional to the input signal. Figure 22 shows a typical application circuit where the AD7400 is used to provide isolation between the analog input, a current sensing resistor, and the digital output, which is then processed by a digital filter to provide an N-bit word.

ANALOG INPUT

The differential analog input of the AD7400 is implemented with a switched capacitor circuit. This circuit implements a second-order modulator stage that digitizes the input signal into a 1-bit output stream. The sample clock (MCLKOUT) provides the clock signal for the conversion process as well as the output data-framing clock. This clock source is internal on the AD7400. The analog input signal is continuously sampled by the modulator and compared to an internal voltage reference. A digital stream that accurately represents the analog input over time appears at the output of the converter (see Figure 20).



Figure 20. Analog Input vs. Modulator Output

A differential signal of 0 V results (ideally) in a stream of 1s and 0s at the MDAT output pin. This output is high 50% of the time and low 50% of the time. A differential input of 200 mV produces a stream of 1s and 0s that are high 81.25% of the time. A differential input of -200 mV produces a stream of 1s and 0s that are high 18.75% of the time.

A differential input of 320 mV results in a stream of, ideally, all 1s. This is the absolute full-scale range of the AD7400, while 200 mV is the specified full-scale range, as shown in Table 8.

Table 8. Analog Input Range

Analog Input	Voltage Input
Full-Scale Range	+640 mV
Positive Full Scale	+320 mV
Positive Specified Input Range	+200 mV
Zero	0 mV
Negative Specified Input Range	−200 mV
Negative Full Scale	−320 mV

To reconstruct the original information, this output needs to be digitally filtered and decimated. A Sinc³ filter is recommended because this is one order higher than that of the AD7400 modulator. If a 256 decimation rate is used, the resulting 16-bit word rate is 39 kHz, assuming a 10 MHz internal clock frequency. Figure 21 shows the transfer function of the AD7400 relative to the 16-bit output.

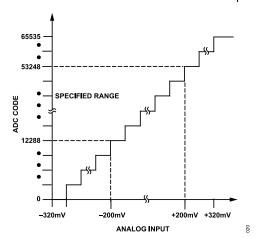


Figure 21. Filtered and Decimated 16-Bit Transfer Characteristic

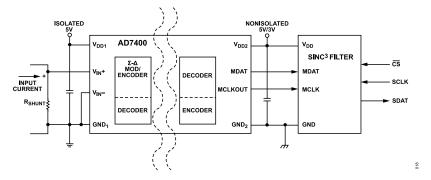


Figure 22. Typical Application Circuit

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THEORY OF OPERATION

DIFFERENTIAL INPUTS

The analog input to the modulator is a switched capacitor design. The analog signal is converted into charge by highly linear sampling capacitors. A simplified equivalent circuit diagram of the analog input is shown in Figure 23. A signal source driving the analog input must be able to provide the charge onto the sampling capacitors every half MCLKOUT cycle and settle to the required accuracy within the next half cycle.

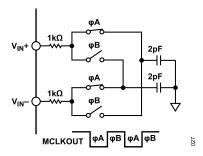


Figure 23. Analog Input Equivalent Circuit

Because the AD7400 samples the differential voltage across its analog inputs, low noise performance is attained with an input circuit that provides low common-mode noise at each input. The amplifiers used to drive the analog inputs play a critical role in attaining the high performance available from the AD7400.

When a capacitive load is switched onto the output of an op amp, the amplitude momentarily drops. The op amp tries to correct the situation and, in the process, hits its slew rate limit. This nonlinear response, which can cause excessive ringing, can lead to distortion. To remedy the situation, a low-pass RC filter can be connected between the amplifier and the input to the AD7400. The external capacitor at each input aids in supplying the current spikes created during the sampling process, and the resistor isolates the op amp from the transient nature of the load.

The recommended circuit configuration for driving the differential inputs to achieve best performance is shown in Figure 24. A capacitor between the two input pins sources or sinks charge to allow most of the charge that is needed by one input to be effectively supplied by the other input. The series resistor again isolates any op amp from the current spikes created during the sampling process. Recommended values for the resistors and capacitor are 22 Ω and 47 pF, respectively.

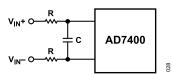


Figure 24. Differential Input RC Network

DIGITAL FILTER

A Sinc³ filter is recommended for use with the AD7400. This filter can be implemented on an FPGA or a DSP. The following Verilog

code provides an example of a Sinc³ filter implementation on a Xilinx[®] Spartan-II 2.5 V FPGA. This code can possibly be compiled for another FPGA, such as an Altera[®] device. Note that the data is read on the negative clock edge in this case, although it can be read on the positive edge if preferred. Figure 28 shows the effect of using different decimation rates with various filter types.

```
/*`Data is read on negative clk edge*/ mod▶
ule DEC256SINC24B(mdata1, mclk1, reset, DATA);
input mclk1;
                    /*used to clk filter*/ in▶
                    /*used to reset filter*/ in▶
put reset;
              /*ip data to be filtered*/
put mdata1;
output [15:0] DATA;
                            /*filtered op*/
integer location; integer info file;
reg [23:0]
                  ip data1;
reg [23:0]
                  acc1;
reg [23:0]
                  acc2;
req [23:0]
                  acc3;
reg [23:0]
                  acc3 d1;
reg [23:0]
                  acc3 d2;
    [23:0]
                  diff1;
rea
                  diff2;
rea
    [23:0]
rea
    [23:0]
                  diff3;
    [23:0]
                  diff1 d;
reg [23:0]
                  diff2 d;
   [15:0]
                  DATA;
reg
                 word count;
req [7:0]
                  reg init;
reg word clk;
/*Perform the Sinc ACTION*/
always @ (mdata1) if(mdata1==0)
                                        ip da▶
ta1 <= 0;
                 /
^{\star} change from a 0 to a -1 for 2's comp ^{\star}/ else
      ip data1 <= 1;
/*ACCUMULATOR (INTEGRATOR) Perform the accumu▶
lation (IIR) at the speed of the modulator.
```

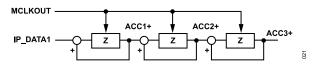


Figure 25. Accumulator

```
Z = one sample delay MCLKOUT = modulators con
version bit rate */
always @ (negedge mclk1 or posedge re▶
set) if (reset)
                     begin
                                   /*initial▶
ize acc registers on re▶
set*/
           acc1 <= 0;
                           acc2 <= 0;
                                            acc3
<= 0;
           end else
                                       /*per▶
                          begin
form accumulation proc▶
ess*/
        acc1 <= acc1 + ip da▶
tal;
          acc2 \le acc2 + acc\overline{1};
                                     acc3 <= acc
3 + acc2;
                end
/*DECIMATION STAGE (MCLKOUT/ WORD CLK) */
```

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THEORY OF OPERATION

```
always @ (posedge mclk1 or posedge re▶
set) if (re▶
set) word_count <= 0; else word
d_count <= word_count + 1;
al▶
ways @ (word_count) word_clk <= word_co
unt[7];
/*DIFFERENTIATOR (including decimation stage)
Perform the differentia▶
tion stage (FIR) at a lower speed.
```

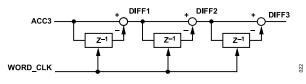


Figure 26. Differentiator

```
Z = one sample delay WORD CLK = out▶
put word rate */
always @ (posedge word clk or posedge re▶
set) if(reset)
                 be▶
    acc3 d2 <= 0;
                         diff1 d <= 0;
diff2 d <= 0; diff1 <= 0; diff2 <= 0;
     diff3 <= 0;
                    end
     begin
                   diff1 <= acc3 -
else
acc3 d2;
             diff2 <= diff1 -
              diff3 <= diff2 -
diff1 d;
diff2 d;
             acc3 d2 \le acc3;
                                  diff1 d <=
            diff2 \overline{d} \leftarrow diff2;
diff1;
/* Clock the Sinc output into an output regis▶
ter
```



Figure 27. Clocking Sinc Output into an Output Register

```
WORD_CLK = output word rate */
always @ (posedge word_clk) begin
DATA[15] <= diff3[23]; DAD

TA[14] <= diff3[22]; DATA[13] <= diff3[21]; DAD

TA[12] <= diff3[20]; DATA[11] <= diff3[19]; DAD

TA[10] <= diff3[18]; DATA[9] <= diff3[17]; DAD

TA[8] <= diff3[16]; DATA[7] <= diff3[15]; DAD

TA[6] <= diff3[14]; DATA[5] <= diff3[13]; DAD

TA[4] <= diff3[12]; DATA[3] <= diff3[11]; DAD

TA[2] <= diff3[10]; DATA[1] <= diff3[9]; DAD

TA[0] <= diff3[8];
end
endmodule
```

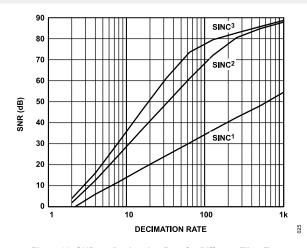


Figure 28. SNR vs. Decimation Rate for Different Filter Types

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APPLICATIONS INFORMATION

GROUNDING AND LAYOUT

Supply decoupling with a value of 100 nF is strongly recommended on both V_{DD1} and V_{DD2} . Decoupling on one or both V_{DD1} pins does not significantly affect performance. In applications involving high common-mode transients, care should be taken to ensure that board coupling across the isolation barrier is minimized. Furthermore, the board layout should be designed so that any coupling that occurs equally affects all pins on a given component side. Failure to ensure this may cause voltage differentials between pins to exceed the absolute maximum ratings of the device, thereby leading to latch-up or permanent damage. Any decoupling used should be placed as close to the supply pins as possible.

Series resistance in the analog inputs should be minimized to avoid any distortion effects, especially at high temperatures. If possible, equalize the source impedance on each analog input to minimize offset. Beware of mismatch and thermocouple effects on the analog input PCB tracks to reduce offset drift.

EVALUATING THE AD7400 PERFORMANCE

A simple standalone AD7400 evaluation board is available with split ground planes and a board split beneath the AD7400 package to ensure isolation. This board allows access to each pin on the device for evaluation purposes. External supplies and all other circuitry (such as a digital filter) must be provided by the user.

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OUTLINE DIMENSIONS

Package Drawing (Option)	Package Type	Package Description	
RW-16	SOIC_W	16-Lead Standard Small Outline Package	

For the latest package outline information and land patterns (footprints), go to Package Index.

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option
AD7400YRWZ	-40°C to +105°C	16-Lead Standard Small Outline Package [SOIC_W]	RW-16
AD7400YRWZ-REEL	-40°C to +105°C	16-Lead Standard Small Outline Package [SOIC_W]	RW-16
AD7400YRWZ-REEL7	-40°C to +105°C	16-Lead Standard Small Outline Package [SOIC_W]	RW-16

¹ Z = RoHS Compliant Part.

EVALUATION BOARDS

Model ¹	Description
EVAL-AD7400EDZ	Evaluation Board
EVAL-CED1Z	Development Board

¹ Z = RoHS Compliant Part.

